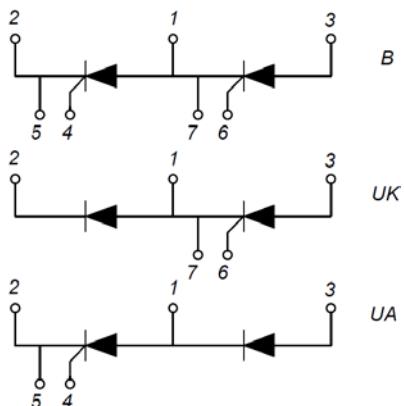


PRODUCT FEATURES

- Electrically Isolated by DBC Ceramic
- High Surge Current Capability
- Low Inductance Package

APPLICATIONS

- DC Motor Control and Drives
- Battery Charges ,Heater controls,Light dimmers
- Static switches



MAXIMUM VOLTAGE RATINGS

$T_C = 25^\circ\text{C}$ unless otherwise specified

Module Type	V_{RRM}/V_{DRM}	V_{RSM}	Unit
MMK200S080B	800	900	V
MMK200S120B	1200	1300	
MMK200S140B	1400	1500	
MMK200S160B	1600	1700	
MMK200S180B	1800	1900	
MMK200S200B	2000	2100	
MMK200S220B	2200	2300	

ABSOLUTE MAXIMUM RATINGS (Thyristor)

Symbol	Parameter/Test Conditions	Values	Unit
$I_{T(AV)}$	Average On State Current	Single phase, half wave, 180° conduction, $T_C = 80^\circ\text{C}$	A
$I_{T(RMS)}$	R.M.S. On State Current		
I_{TSM}	Non Repetitive Surge On State Current	$1/2$ cycle, 50/60Hz, peak value, $T_C = 45^\circ\text{C}$	5000/5400
I^2t	I^2t (For Fusing)	$1/2$ cycle, 50/60Hz, peak value, $T_C = 45^\circ\text{C}$	125/121 KA^2s
T_J	Junction Temperature(Thyristor)	-40 to +125	$^\circ\text{C}$

ABSOLUTE MAXIMUM RATINGS (Diode)

Symbol	Parameter/Test Conditions	Values	Unit
$I_{F(AV)}$	Average Forward Current	Single phase, half wave, 180° conduction, $T_C = 95^\circ\text{C}$	A
$I_{F(RMS)}$	R.M.S. Forward Current		
I_{FSM}	Non Repetitive Surge Forward Current	$1/2$ cycle, 50/60Hz, peak value, $T_C = 45^\circ\text{C}$	6800/7300
I^2t	For Fusing	$1/2$ cycle, 50/60Hz, peak value, $T_C = 45^\circ\text{C}$	231.2/221.1 KA^2s

ELECTRICAL CHARACTERISTICS (Thyristor) $T_C = 25^\circ\text{C}$ unless otherwise specified

Symbol	Parameter/Test Conditions	Min.	Typ.	Max.	Unit	
I_{DRM}	Maximum Peak Off-State Current $V_D = V_{DRM}, T_J = 125^\circ\text{C}$			25	mA	
I_{RRM}	Maximum Peak Reverse Current $V_R = V_{RRM}, T_J = 125^\circ\text{C}$			25		
V_{TM}	Maximum on state voltage drop $I_{TM}=500\text{A}, t_d=10\text{ ms, half sine}$			1.75	V	
V_{TO}	For power loss calculations only	$T_J = 125^\circ\text{C}$		0.80	V	
r_T				2.0	$\text{m}\Omega$	
V_{GT}	Max. required DC gate voltage to trigger	$V_A=6\text{V}, R_A=1\Omega, T_J = -40^\circ\text{C}$		4.0	V	
		$V_A=6\text{V}, R_A=1\Omega$		1.0		
		$V_A=6\text{V}, R_A=1\Omega, T_J = 125^\circ\text{C}$		1.7		
I_{GT}	Max. required DC gate current to trigger	$V_A=6\text{V}, R_A=1\Omega, T_J = -40^\circ\text{C}$		270	mA	
		$V_A=6\text{V}, R_A=1\Omega$		75		
		$V_A=6\text{V}, R_A=1\Omega, T_J = 125^\circ\text{C}$		80		
V_{GD}	Max. required DC gate voltage not to trigger, $V_D = V_{DRM}, T_J = 125^\circ\text{C}$			0.25	V	
I_{GD}	Max. required DC gate current not to trigger, $V_D = V_{DRM}, T_J = 125^\circ\text{C}$			6	mA	
I_H	Maximum holding current			100	200	mA
I_L	Maximum latching current			200	400	mA
P_{GM}	Maximum peak gate power			12	W	
$P_{G(AV)}$	Maximum average gate power			3.0		
I_{GM}	Maximum peak gate current			3.0	A	
$-V_{GM}$	Maximum peak negative gate voltage			10	V	
dv/dt	Critical Rate of Rise of Off-State Voltage, $T_J=125^\circ\text{C}$, exponential to 67% rated V_{DRM}			1000	$\text{V}/\mu\text{s}$	
di/dt	Max.Rate of Rise of Turned on Current, $T_J = 125^\circ\text{C}, I_{TM}=500\text{A}$, rated V_{DRM}			150	$\text{A}/\mu\text{s}$	

ELECTRICAL CHARACTERISTICS (Diode)

Symbol	Parameter/Test Conditions	Min.	Typ.	Max.	Unit
I_{RM}	Maximum Reverse Leakage Current	$V_R = V_{RRM}$		0.5	mA
		$V_R = V_{RRM}, T_J = 125^\circ\text{C}$		10	
V_F	Forward Voltage Drop $I_F=500\text{A}$			1.5	V
V_{TO}	For power-loss calculations only , $T_J = 125^\circ\text{C}$			0.9	V
r_T				1.0	$\text{m}\Omega$

MODULE CHARACTERISTICS $T_C = 25^\circ\text{C}$ unless otherwise specified

T_J	Junction Temperature		-40 to +125	$^\circ\text{C}$
T_{STG}	Storage Temperature Range		-40 to +125	$^\circ\text{C}$
V_{ISO}	Isolation Breakdown Voltage	AC, 50Hz(R.M.S), $t=1\text{ minute}$	3000	V
Torque	to heatsink	Recommended (M6)	3~5	Nm
Torque	to terminal	Recommended (M6)	3~5	Nm
R_{thJC}	Junction-to-Case Thermal Resistance(Per Thyristor/Per Diode)		0.12/0.14	K /W
Weight			160	g

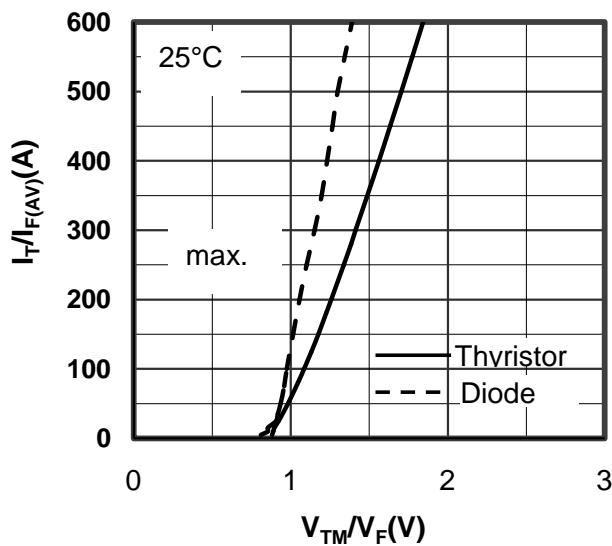


Figure 1. Forward Voltage Drop vs Forward Current

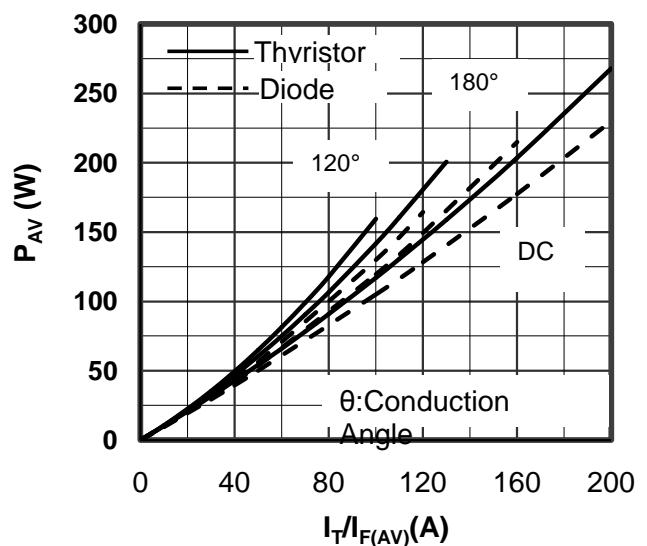


Figure 2. Power dissipation vs. $I_T/I_{F(AV)}$

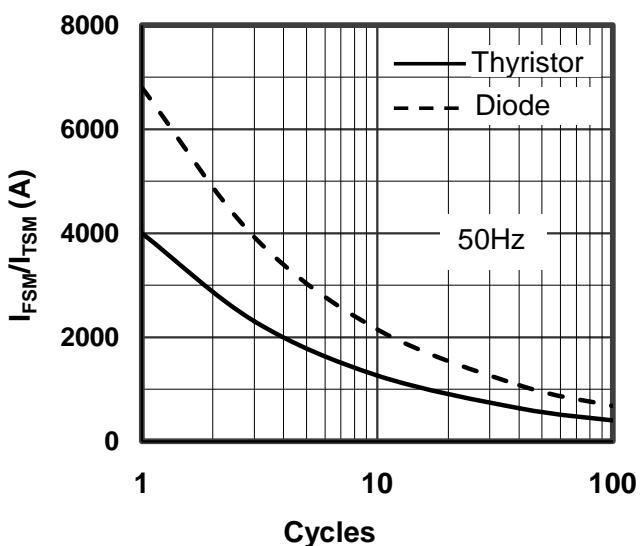


Figure 3. Diode and SCR Max Non-Repetitive Surge

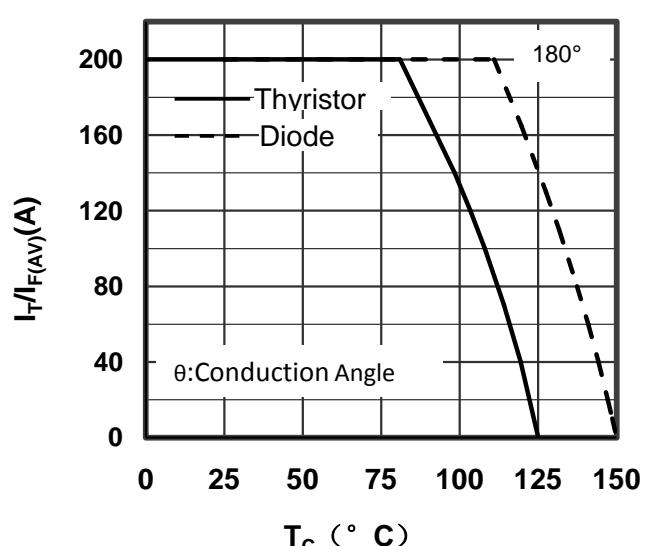


Figure 4. Diode $I_{F(AV)}$ and SCR $I_{T(AV)}$ vs. T_C

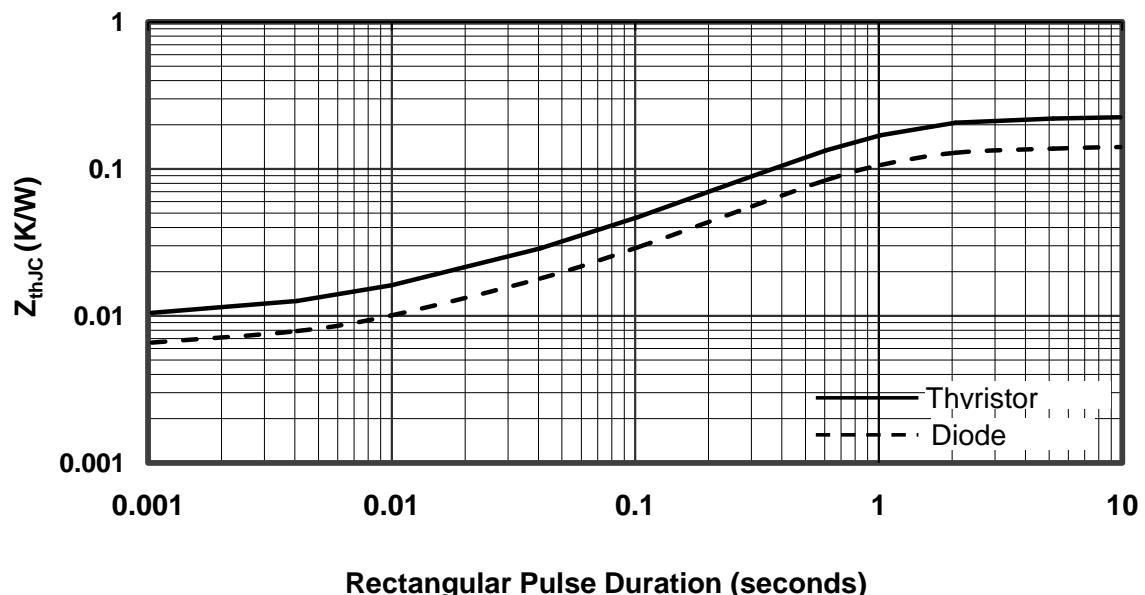


Figure 5. Transient Thermal Impedance of Diode and SCR

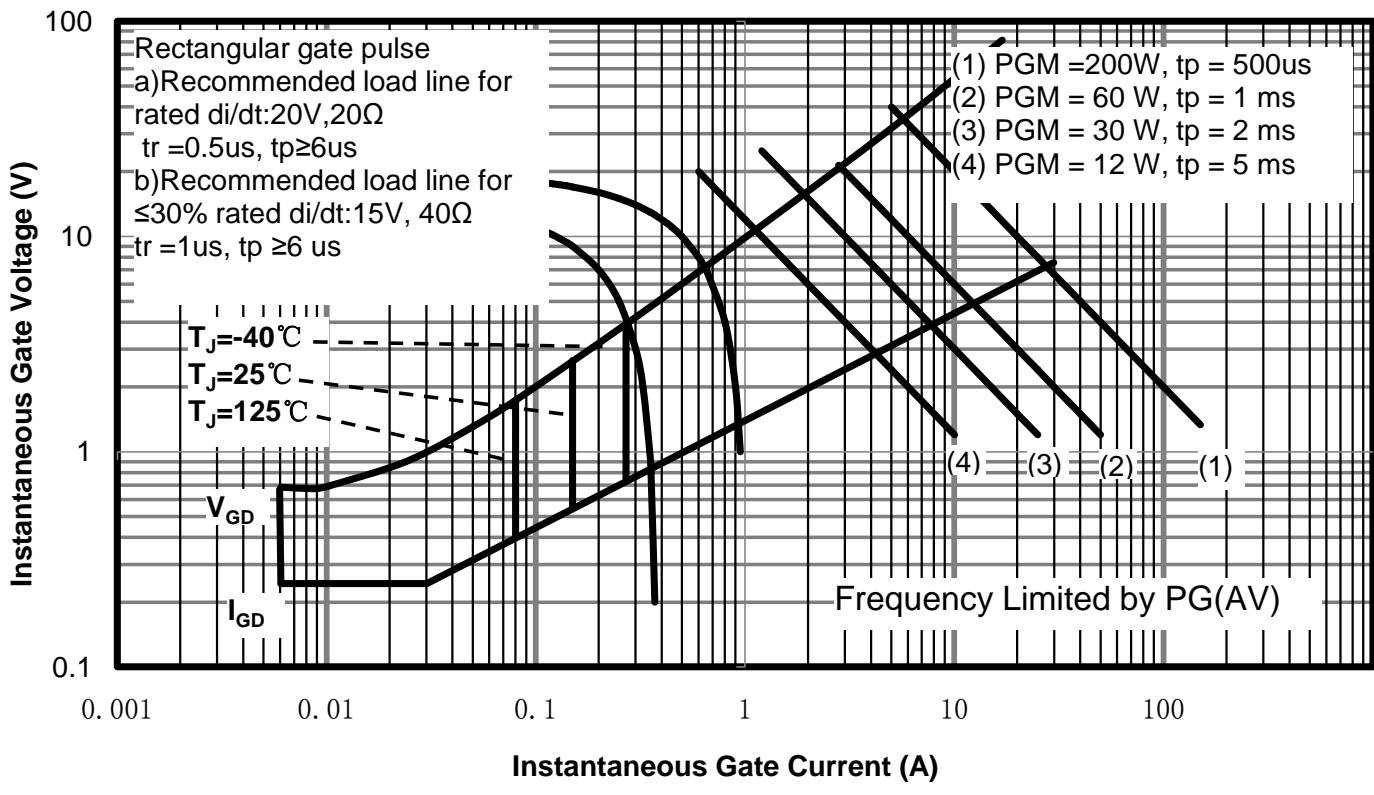
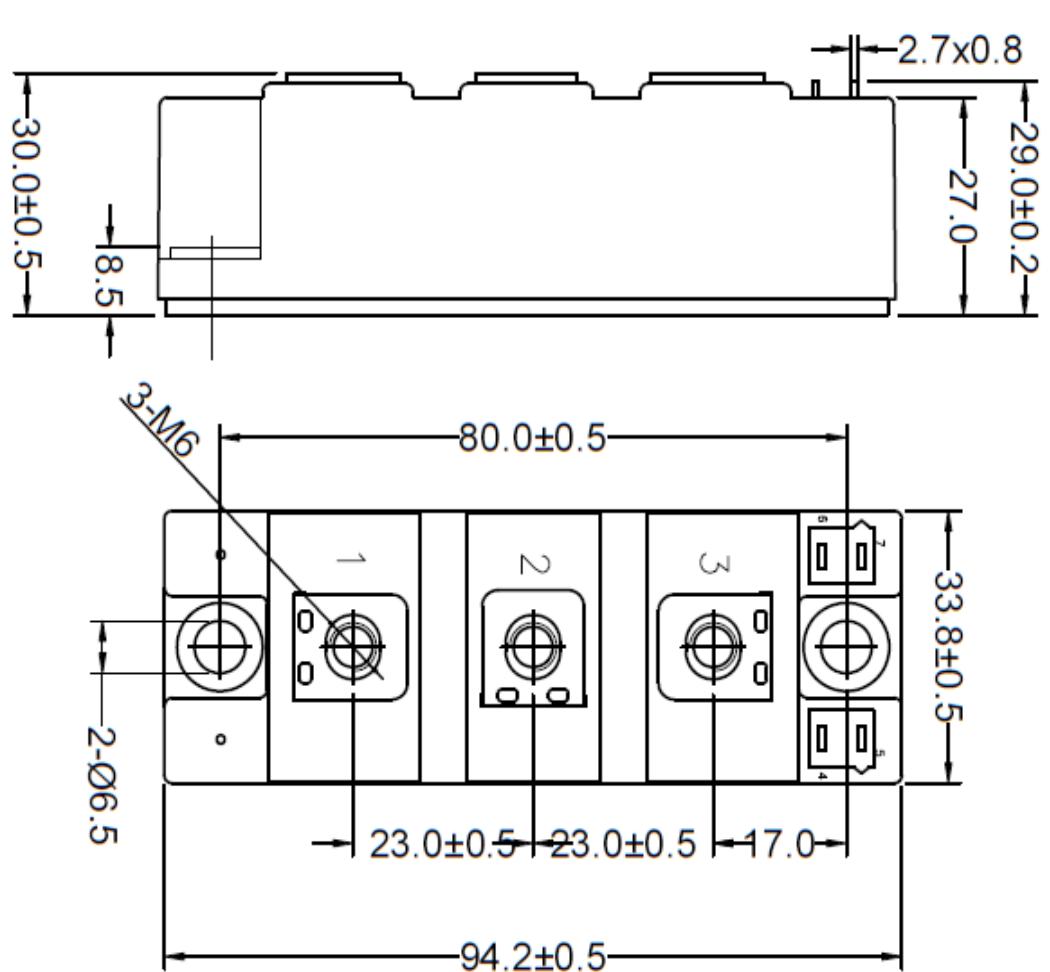


Figure 6. SCR Gate Characteristics



Dimensions in (mm)
Figure 7. Package Outline